



PIER GIORGIO MERLI (S)TEM SCHOOL IN MATERIALS SCIENCE

19-23 November 2018 - Theory 4-8 February 2019 - Practical

> CNR IMM Bologna Via Gobetti 101, 40129 - Bologna, Italy

DIRECTORS

Andrea PARISINI and Vittorio MORANDI

TEACHERS

Aldo Armigliato, Roberto Balboni, Giorgio Lulli, Andrea Migliori, Vittorio Morandi, Luca Ortolani, Andrea Parisini - *CNR IMM Bologna*

> Matteo Ferroni - *University of Brescia* Giovanni Bertoni - *CNR IMEM Parma* Gianluca Calestani - *University of Parma*

> > http://temschool.bo.imm.cnr.it

The 7th edition of the "Pier Giorgio Merli" Transmission Electron Microscopy School, jointly organised by SISM and CNR-IMM, in two full weeks, will provide students and researchers with a qualified introduction to TEM and STEM techniques for materials science.

In the first week, after an introduction to the (S)TEM working principles, the theoretical background of SAED, CBED, HREM, HAADF-STEM, EELS, EDS and Holography will be detailed. Examples of applications will include crystallographic phases identification, strain determination, studies of lattice defects, nanoparticles and nanotubes characterization in solids and devices, compositional investigations, analysis of phase variations.

In the second week, the knowledge acquired during the first part of the School will be put into practice. Students, under teacher's supervision, will operate on the 200 kV Schottky FEG TEM-STEM (FEI Tecnai F20 ST) installed at the CNR-IMM Institute. Students will be also trained to the use of some of the available simulation and data processing software essential for (S)TEM work.

A certificate of attendance will be given to all the participants and upon request a certificate of the acquired skills, that may be also used for academic credits, will be issued after an examination.

As participation to the School is open to people from all countries the official language is English.

Please refer to the School's web site, for a more complete description of the School's subjects:

http://temschool.bo.imm.cnr.it

REGISTRATION

Registration to the school is obtained by signing up before September 30, 2018, directly on the SISM website http://www.sism.it

Theory		Theory + Pra	Theory + Practical		
SISM Member	560€	SISM Member	1360€		
Non Member	700€	Non Member	1700€		

The fee includes participation to the courses, education materials, coffee breaks and lunches to the local CNR canteen. Students and young researchers with a temporary position can claim an additional 30% discount on the fees (VAT excluded).

For any payment an invoice will be issued. Please note that, for employees of Italian public institutions, the fee is exempt from VAT (Article 10 of DPR 633/72).

Registration fees may be paid through:

Credit card

SISM website: http://www.sism.it

Bank transfer

S.I.S.M IBAN: IT 43 Q 02008 02455 000103039142 BIC-SWIFT: UNCRITM1PM5 Address: Unicredit - Ag. Dante, Bologna Reference: "Name of the participant + BOTEM2018"

Important notice: participants may choose to attend either the whole course or the theoretical part only (it is not possible to register for the practical course only). As to the practical course, to guarantee enough operating time to all the students, *the maximum number of participants is limited to 10*. The School will take place only if a *minimum number of 6 registrations* to both the theoretical and practical courses will be reached.

PROGRAM OF THEORETICAL WEEK

Mon	day 19 th	Tues	day 20 th	Wed	nesday 21 st	Thur	sday 22 nd	Frida	ay 23 rd
09:00	REGISTRATION	09:00	Radiation Damage	09:00	Theory of Electron Diffraction		High Resolution	09:30	Electron Energy Loss Spectroscopy
10:00	Electron Optics <i>G. Lulli</i>	10:00	Electron-Matter Interaction <i>R. Balboni</i>		A. Parisini	03.30	Electron Microscopy 1 A. Parisini		G. Bertoni
11:30	COFFEE BREAK	11:00	COFFEE BREAK	11:00	COFFEE BREAK	11:00	COFFEE BREAK	11:00	COFFEE BREAK
12:00	Electron Sources <i>V. Morandi</i>	11:30	Elements of Crystallography <i>G. Calestani</i>	11:30	X-Ray Microanalysis of Thin Films <i>M. Ferroni</i>	11:30	High Resolution Electron Microscopy 2 <i>A. Parisini</i>	<u>11:30</u>	Electron Holography and Interferometric Methods <i>L. Ortolani</i>
13:00	LUNCH					13:00	LUNCH		
		13:30	LUNCH	13:30	LUNCH			13:30	LUNCH
14:30	Instrumentation and Detectors	 	Introduction to electron		Convergent Beam	14:30	Scanning Transmission Electron Microscopy 1	14:30	In-Situ TEM To be defined
	M. Ferroni		diffraction in materials <i>R. Balboni</i>		Electron Diffraction R. Balboni		V. Morandi	15:30	TEM Manufacturers
16:00	COFFEE BREAK	16:00	COFFEE BREAK	16:00	COFFEE BREAK	16:00	COFFEE BREAK		Presentations
16:30	Introduction to Aberrations Correction <i>L. Ortolani</i>	16:30	A Diffraction Experiment: The Arago-Poisson's Spot <i>A. Parisini</i>	16:30	To be defined	<u>16:30</u>	Scanning Transmission Electron Microscopy 2 V. Morandi	- 16:30	Final discussion and Closing Remarks
17:30		17:30		17:30				17:30	
						18:00			

PROGRAM OF PRACTICAL WEEK February 2019

Tues	day 05 th	
	Group A	Group B
09:00	 Electron Diffraction Balboni 	Diffraction Pattern Indexing <i>Migliori/Ortolani</i>
10:30	COFFEE BREAK	
11:00	Electron Diffraction Balboni	Introduction to HREM Parisini
12:30	LUNCH	
14:00	Diffraction Pattern Indexing Migliori/Ortolani	 Electron Diffraction Balboni
15:30	COFFEE BREAK	
16:00	Introduction to HREM Parisini	 Electron Diffraction Balboni
17:30		

Wednesday 06th

• HREM	
Parisini	HREM Simulations Migliori/Morandi
COFFEE BREAK	
HREM Parisini	Image Processing <i>Ortolani</i>
LUNCH	
HREM Simulations Migliori/Morandi	• HREM Parisini
COFFEE BREAK	
Image Processing <i>Ortolani</i>	• HREM Parisini
	 HREM Parisini LUNCH HREM Simulations Migliori/Morandi COFFEE BREAK Image Processing

Monday 04th

Thursday 07th

	Group A	Group B
14:00	 Introduction to TEM <i>Ortolani</i> 	Introduction to Electron Diffraction <i>R. Balboni</i>
15:30	COFFEE BREAK	
16:00	Introduction to Electron Diffraction <i>R. Balboni</i>	 Introduction to TEM <i>L. Ortolani</i>
17.30		

Friday 08th

	Group A	Group B	
9:00	⊙ STEM Morandi	TEM Sample Preparation <i>Ferroni</i>	-
0:30	COFFEE BREAK		
1:00	STEM Morandi	FIB Sample Preparation <i>Ortolani</i>	
2:30	LUNCH		
4:00	TEM Sample Preparation <i>Ferroni</i>	STEM Morandi	
5:30	COFFEE BREAK		
6:00	FIB Sample Preparation <i>Ortolani</i>	STEM Morandi	
7:30			

	Group A	Group B
09:00	 EDX Spectra Acquisitium Parisini 	EDX Spectra Processing <i>Migliori/Balboni</i>
10:30	COFFEE BREAK	
11:00	EDX Spectra Processing <i>Migliori/Balboni</i>	 EDX Spectra Acquisitium Parisini
12:30	LUNCH	

14:00 CLOSING OF THE SCHOOL

15:30

17:30